

Single P-Channel MOSFET

DESCRIPTION

The SMC3241 uses trench MOSFET technology Provides extremely low $R_{DS(ON)}$, Low resistance package and excellent fast switching performance. This device is ideal for efficient and fast switching applications.

PART NUMBER INFORMATION

SMC 3241 H - TR G
 a b c d e

a : Company name.
 b : Product Serial number.
 c : Package code H:TO-252
 d : Handling code TR:Tape&Reel
 e : Green produce code G:RoHS Compliant

FEATURES

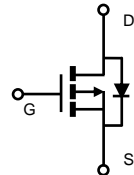
$V_{DS} = -30V$, $I_D = -38A$

$R_{DS(ON)} = 16m\Omega(Typ.)@V_{GS} = -10V$
 $R_{DS(ON)} = 24.5m\Omega(Typ.)@V_{GS} = -4.5V$

- ◆ 100% EAS Guarantee
- ◆ High power and current handling capability

APPLICATIONS

- ◆ Power Management
- ◆ DC/DC Converters



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-Source Voltage	-30	V
V_{GSS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current	$T_C = 25^\circ C$	-38
		$T_C = 100^\circ C$	-24
I_{DM}	Pulsed Drain Current ^A	-152	A
I_D	Continuous Drain Current	$T_A = 25^\circ C$	-12.7
		$T_A = 70^\circ C$	-10.2
P_D	Power Dissipation ^B	$T_A = 25^\circ C$	5
		$T_A = 70^\circ C$	3.2
I_{AS}	Avalanche Current ^A	-25	A
E_{AS}	Single Pulse Avalanche energy $L=0.1mH$ ^{AF}	31	mJ
P_D	Power Dissipation ^C	$T_C = 25^\circ C$	44.6
		$T_C = 100^\circ C$	17.9
T_J	Operation Junction Temperature	-55/150	$^\circ C$
T_{STG}	Storage Temperature Range	-55/150	$^\circ C$

THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ^B	$t \leq 10s$	25	$^\circ C/W$
	Thermal Resistance Junction to Ambient ^{BD}	Steady-State	50	
$R_{\theta JC}$	Thermal Resistance Junction to Case		2.8	

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ Unless otherwise noted)

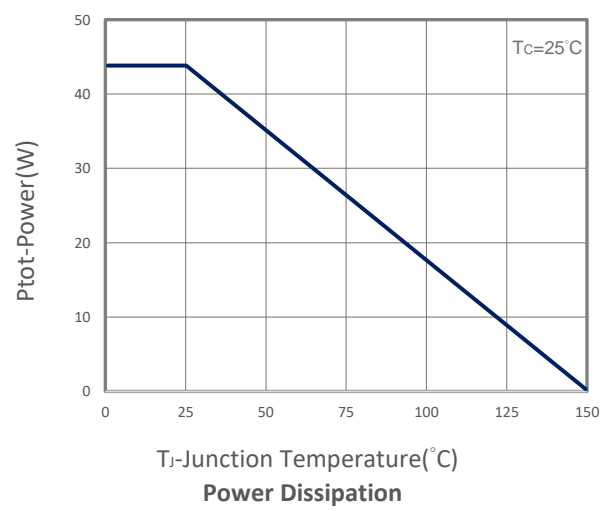
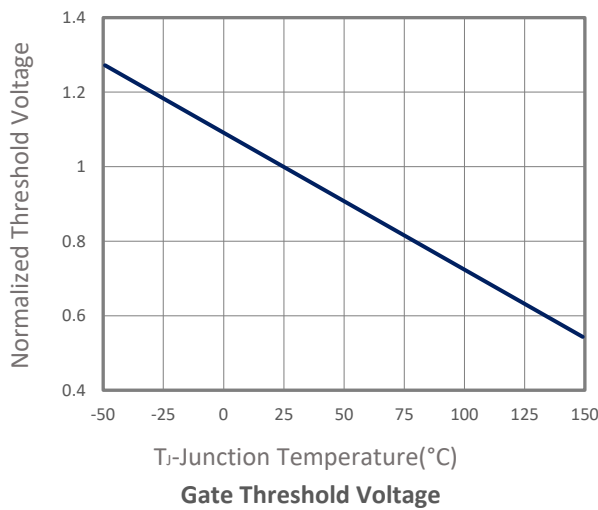
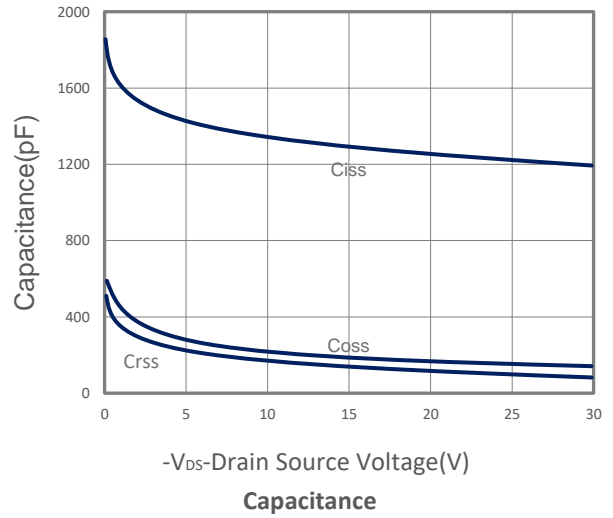
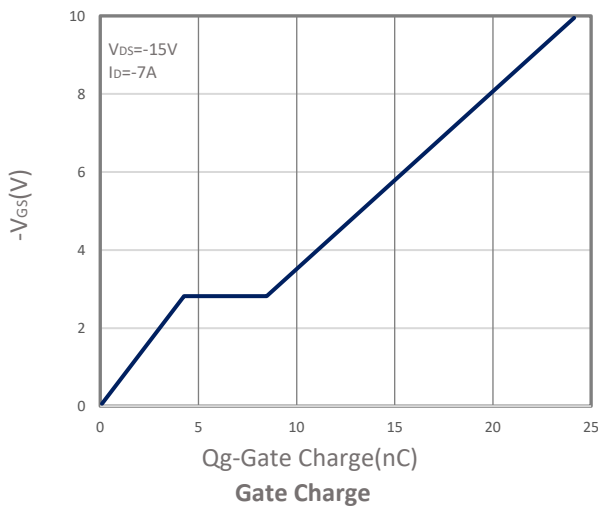
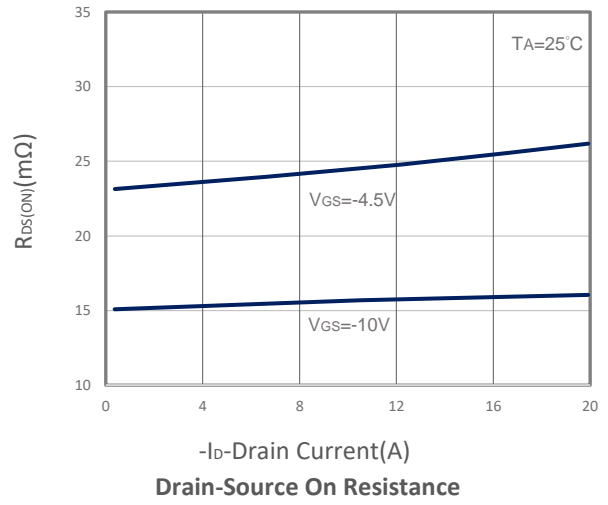
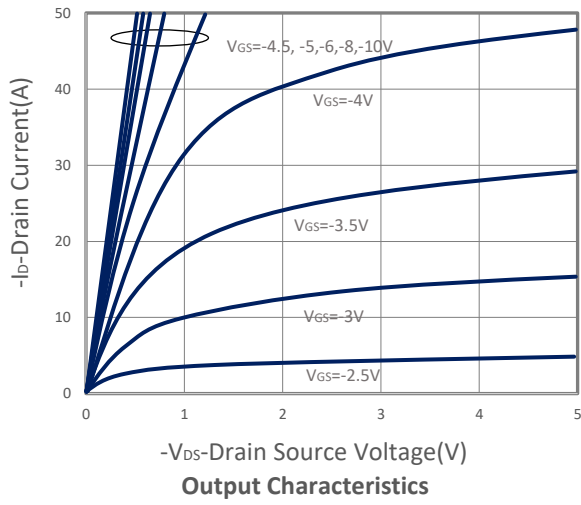
Symbol	Parameter	Condition	Min	Typ	Max	Unit
Static Parameters						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-30			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1	-1.6	-2.5	V
I_{GSS}	Gate Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$			± 100	nA
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-30V, V_{GS}=0V, T_J=25^\circ\text{C}$			-1	μA
		$V_{DS}=-24V, V_{GS}=0V, T_J=75^\circ\text{C}$			-10	
$R_{DS(ON)}$	Drain-source On-Resistance ^E	$V_{GS}=-10V, I_D=-12.7A$ $V_{GS}=-4.5V, I_D=-8A$		16 24.5	20 29	$m\Omega$
G_{fs}	Forward Transconductance	$V_{DS}=-10V, I_D=-10A$		22		S
Diode Characteristics						
V_{SD}	Diode Forward Voltage ^E	$I_S=-1A, V_{GS}=0V$		-0.7	-1	V
I_S	Continuous Source Current				-38	A
t_{rr}	Reverse Recovery Time	$I_S=-10A, dI/dt=100A/\mu s$		12		ns
Q_{rr}	Reverse Recovery Charge			5		nC
Dynamic and Switching Parameters						
Q_g	Total Gate Charge	$V_{DS}=-15V, V_{GS}=-10V, I_D=-7A$		23.6	33	nC
Q_g	Total Gate Charge (4.5V)			11.5	16.1	
Q_{gs}	Gate-Source Charge			4.2	5.9	
Q_{gd}	Gate-Drain Charge			4.4	6.2	
C_{iss}	Input Capacitance	$V_{DS}=-15V, V_{GS}=0V, f=1\text{MHz}$		1280		μF
C_{oss}	Output Capacitance			175		
C_{rss}	Reverse Transfer Capacitance			125		
$t_{d(on)}$	Turn-On Time ^E	$V_{DD}=-15V, V_{GEN}=-10V, R_G=6\Omega, I_D=-1A$		6.1	12	nS
t_r				14	27	
$t_{d(off)}$	Turn-Off Time ^E			34	65	
t_f				13.2	25	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

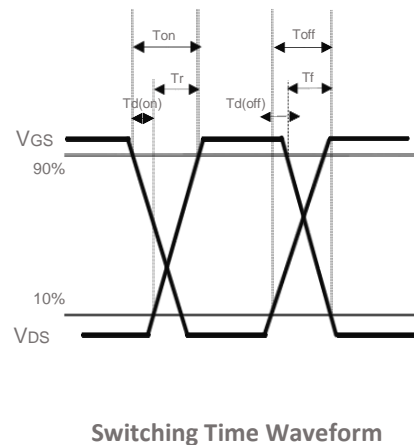
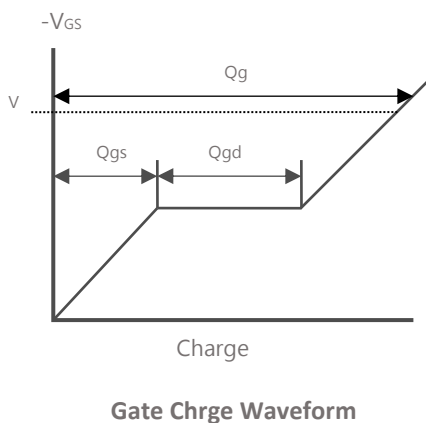
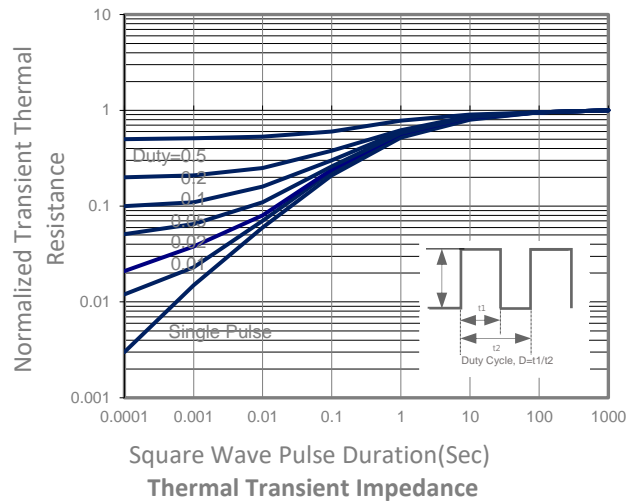
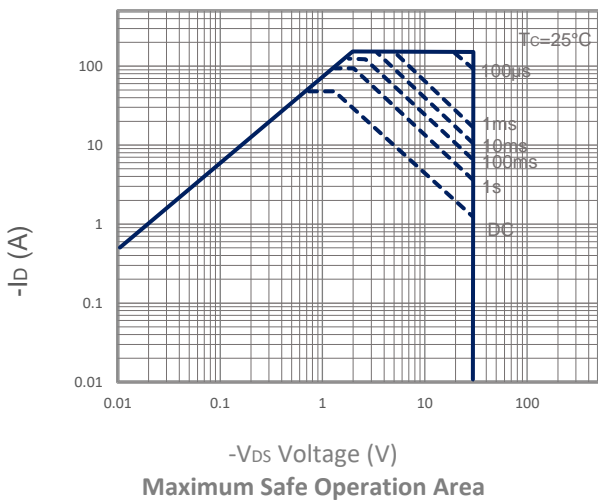
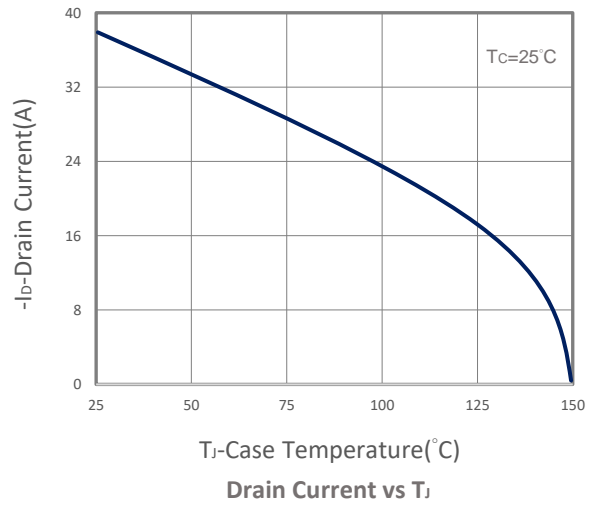
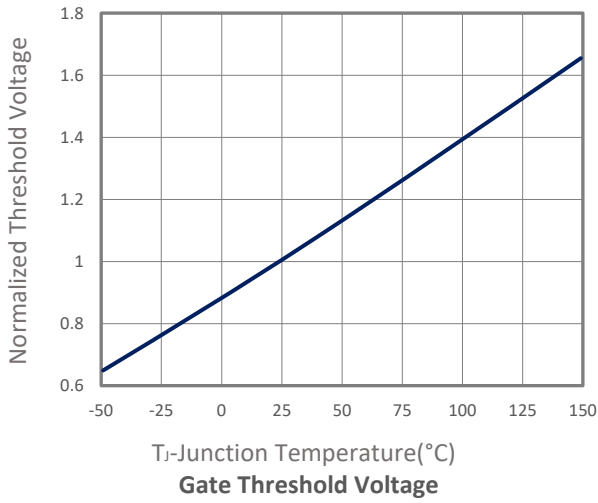
- A. Pulsed width limited by maximum junction temperature, $T_{J(MAX)}=150^\circ\text{C}$.
- B. The value of $R_{\theta JA}$ is measured with the device mounted on 1in2 FR-4 board in a still air environment with maximum junction temperature $T_{J(MAX)}=150^\circ\text{C}$ (initial temperature $T_A=25^\circ\text{C}$).
- C. $T_{J(MAX)}=150^\circ\text{C}$, using junction-to-ambient thermal resistance, $t \leq 10\text{sec}$.
- D. $T_{J(MAX)}=150^\circ\text{C}$, using junction-to-case thermal resistance ($R_{\theta JC}$) is more useful in additional heat sinking is used.
- E. The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
- F. The EAS data shows Max, tested and pulse width limited by $T_{J(MAX)}=150^\circ\text{C}$ (initial temperature $T_J=25^\circ\text{C}$).

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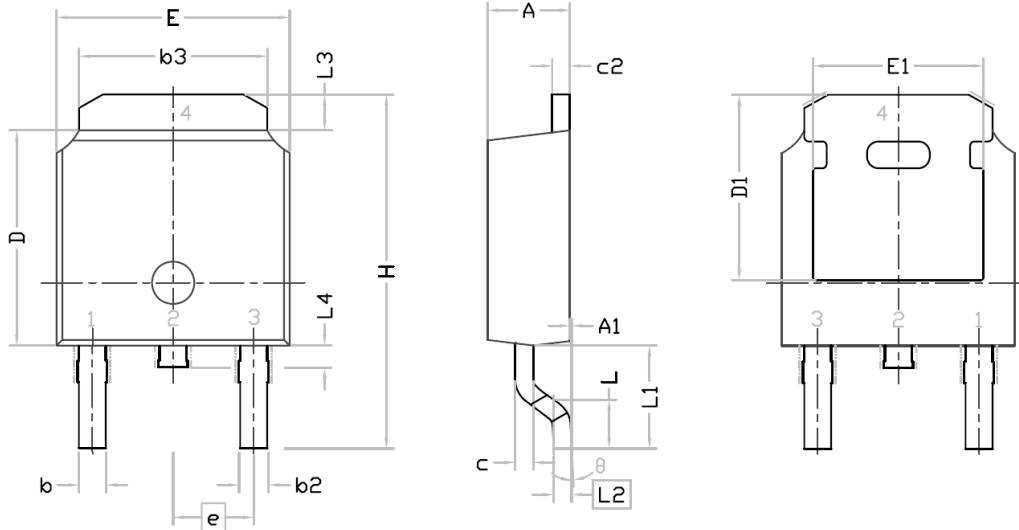
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TO-252 PACKAGE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.380	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.640	0.880	0.025	0.035
b2	0.770	1.140	0.030	0.045
b3	5.210	5.460	0.205	0.215
c	0.460	0.600	0.018	0.024
c2	0.460	0.580	0.018	0.023
D	6.000	6.223	0.236	0.245
D1	5.210	-	0.205	-
E	6.400	6.731	0.252	0.265
E1	4.400	-	0.173	-
e	2.286 BSC.		0.090 BSC.	
H	9.400	10.40	0.370	0.409
L	1.400	1.770	0.055	0.070
L1	2.743 REF.		0.108 REF.	
L2	0.508 BSC.		0.020 BSC.	
L3	0.890	1.270	0.035	0.050
L4	0.640	1.010	0.025	0.040
θ	0°	10°	0°	10°

Recommended Land Pattern

